What is claimed is:

- 1 1. A flexible electronic device comprising: a flexible film;
- 2 a substrate formed on the flexible film, the substrate being
- different from the material of said flexible film and thickness
- 4 of said substrate is larger than 0 μm and not larger than 200
- 5 μ m; and a thin film device formed on the substrate.
- 1 2. The flexible electronic device according to claim 1,
- 2 wherein said flexible electronic device is formed by laminating
- 3 at least two or more components.
- The flexible electronic device according to claim 1,
- 2 wherein said thin film device is a thin film transistor formed
- 3 of a silicon thin film.
- 1 4. The flexible electronic device according to claim 1,
- 2 wherein said substrate is an insulating substrate.
- 1 5. The flexible electronic device according to claim 4,
- 2 wherein said insulating substrate is a glass substrate.
- 1 6. The flexible electronic device according to claim 1,
- 2 wherein said flexible film is an insulating film.
- 1 7. The flexible electronic device according to claim 1,
- 2 wherein said flexible film has a thermal conductivity higher
- 3 than 0.01 W/cm·deg.

- 1 8. The flexible electronic device according to claim 1,
- 2 wherein said flexible film is a laminated structure at least
- 3 comprising a film having a thermal conductivity higher than
- 4 0.01 W/ cm·deg and an insulating film.
- 1 9. A production method of a flexible electronic device
- 2 comprising the steps of:
- 3 forming a thin film device on a substrate;
- 4 adhering a protection film onto said thin film device;
- 5 etching said substrate from a back surface thereof such that
- 6 residual thickness of said substrate is larger than 0 μm and
- 7 not larger than 200 μm ;
- 8 adhering a flexible film onto etched surface of said substrate;
- 9 and peeling said protection film from said thin film device
- 10 after a step of said adhering said flexible film.
- 1 10. The production method of a flexible electronic device
- 2 according to claim 9, wherein said thin film device is a thin
- 3 film transistor formed of a silicon thin film.
- 1 11. The production method of a flexible electronic device
- 2 according to claim 9, wherein said substrate is an insulating
- 3 substrate.
- 1 12. The production method of a flexible electronic device
- 2 according to claim 9, wherein said insulating substrate is a
- 3 glass substrate.

- 1 13. The production method of a flexible electronic device
- 2 according to claim 9, wherein said flexible film is an insulating
- 3 film.
- 1 14. The production method of a flexible electronic device
- 2 according to claim 9, wherein said flexible film has a thermal
- 3 conductivity higher than 0.01 W/cm·deg.
- 1 15. The production method of a flexible electronic device
- 2 according to claim 9, wherein said flexible film is a laminated
- 3 structure at least comprising a film having a thermal
- 4 conductivity higher than 0.01 W/cm·deg and an insulating film.
- 1 16. A production method of a flexible electronic device,
- 2 comprising the steps of laminating a first glass substrate and
- 3 a second glass substrate, each having a thin film device formed
- 4. on one surface thereof, so as for said thin film device formed
- 5 surfaces to adhere to each other; adhering a protection sheet
- 6 on the surface of said first glass substrate other than said
- 7 thin film device formed surface thereof; etching the surface
- 8 of said second glass substrate other than said thin film device
- 9 formed surface thereof until the residual thickness of said
- 10 second glass substrate becomes larger than 0 μm and not larger
- 11 than 200 μ m; adhering a flexible sheet onto the etched surface
- 12 of said first glass substrate; peeling said protection sheet;
- 13 etching the surface of said first glass substrate other than
- 14 said thin film device formed surface thereof until the residual

- 15 thickness of said first glass substrate becomes larger than
- 16 0 μ m and not larger than 200 μ m; and adhering a flexible film
- on to the etched surface of said first glass substrate, wherein
- 18 these steps are successively performed.
 - 1 17. A production method of a flexible electronic device,
 - 2 comprising the steps of laminating a pair of a first glass
 - 3 substrate and a second glass substrate, each having a thin film
 - 4 device formed on one surface thereof, so as for said thin film
 - 5 device formed surfaces to adhere to each other; etching the
 - 6 surfaces of said first glass substrate and said second glass
 - 7 substrate respectively other than said thin film device formed
 - 8 surfaces thereof until the respective residual thicknesses of
- 9 said first glass substrate and said second glass substrate become
- larger than 0 µm and not larger than 200 µm; and adhering flexible
- 11 films respectively onto the etched surfaces of said first glass
- 12 substrate and said second glass substrate, wherein these steps
- 13 are performed successively.
 - 1 18. The production method of a flexible electronic device
 - 2 according to claim 16, wherein said flexible devices are liquid
 - 3 crystal display devices.
 - 1 19. The production method of a flexible electronic device
 - 2 according to claim 17, wherein said flexible devices are liquid
 - 3 crystal display devices.

- 1 20. The production method of a flexible electronic device
- 2 according to claim 16, wherein said flexible films have
- 3 polarizing function and phase difference function.
- 1 21. The production method of a flexible electronic device
- 2 according to claim 17, wherein said flexible films have
- 3 polarizing function and phase difference function.
- 1 22. The production method of a flexible electronic device
- 2 according to any one of claims 9, 16 and 17, wherein in said
- 3 etching step or in each of said etching steps, a confirmation
- 4 substep for measuring the weight or thickness of the substrate
- 5 being etched is performed several times in the course of the
- 6 etching step.